


<b>Search Notes</b> 	<b>Application/Control No.</b> 09631174	<b>Applicant(s)/Patent Under Reexamination</b> DWYER ET AL.
	<b>Examiner</b> Li, Aimee J	<b>Art Unit</b> 2183

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
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<b>SEARCH NOTES</b>		
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